Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/511,380	YAMADA ET AL.
Examiner	Art Unit

Tuan N. Nguyen

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Class	Subclass	Date	Examiner
401	17 23 196 198 199	6/6/2005	AN
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
401	23 198 199	6/13/2005	To s	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST BRS TEXT SEARCH ATTACHED	6/13/2005	E.	
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